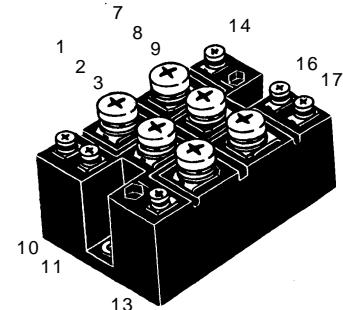
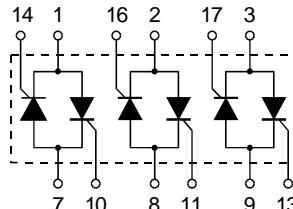


# Three Phase AC Controller Modules

**I<sub>RMS</sub> = 50 A**  
**V<sub>RRM</sub> = 800-1600 V**

Preliminary data

V <sub>RSM</sub> V <sub>DSM</sub> V	V <sub>RRM</sub> V <sub>DRM</sub> V	Type
800	800	VWO 50-08io7
1200	1200	VWO 50-12io7
1400	1400	VWO 50-14io7
1600	1600	VWO 50-16io7



Symbol	Test Conditions	Maximum Ratings		
I <sub>RMS</sub>	T <sub>C</sub> = 85°C, 50 - 400 Hz (per phase)	50	A	
I <sub>TRMS</sub>	T <sub>VJ</sub> = T <sub>VJM</sub>	36	A	
I <sub>TAVM</sub>	T <sub>C</sub> = 85°C; (180° sine)	23	A	
I <sub>TSM</sub>	T <sub>VJ</sub> = 45°C; V <sub>R</sub> = 0	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	520	A
	T <sub>VJ</sub> = T <sub>VJM</sub> V <sub>R</sub> = 0	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	560	A
I <sup>2</sup> t	T <sub>VJ</sub> = 45°C; V <sub>R</sub> = 0	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	460	A
	T <sub>VJ</sub> = T <sub>VJM</sub> V <sub>R</sub> = 0	t = 10 ms (50 Hz), sine t = 8.3 ms (60 Hz), sine	500	A
(di/dt) <sub>cr</sub>	T <sub>VJ</sub> = T <sub>VJM</sub> f = 50 Hz, t <sub>p</sub> = 200 μs V <sub>D</sub> = 2/3 V <sub>DRM</sub> I <sub>G</sub> = 0.3 A di <sub>G</sub> /dt = 0.3 A/μs	repetitive, I <sub>T</sub> = 150 A	100	A/μs
		non repetitive, I <sub>T</sub> = I <sub>TAVM</sub>	500	A/μs
(dv/dt) <sub>cr</sub>	T <sub>VJ</sub> = T <sub>VJM</sub> ; R <sub>GR</sub> = ∞; method 1 (linear voltage rise)	V <sub>DR</sub> = 2/3 V <sub>DRM</sub>	1000	V/μs
P <sub>GM</sub>	T <sub>VJ</sub> = T <sub>VJM</sub> I <sub>T</sub> = I <sub>TAVM</sub>	t <sub>p</sub> = 30 μs t <sub>p</sub> = 300 μs	10 5	W
P <sub>GAVM</sub>			0.5	W
V <sub>RGM</sub>			10	V
T <sub>VJ</sub>			-40...+125	°C
T <sub>VJM</sub>			125	°C
T <sub>stg</sub>			-40...+125	°C
V <sub>ISOL</sub>	50/60 Hz, RMS I <sub>ISOL</sub> ≤ 1 mA	t = 1 min t = 1 s	2500 3000	V~
M <sub>d</sub>	Mounting torque (M5) Terminal connection torque (M3; M5)		5/44±15 % Nm/lb.in. 1.5/13±15 % Nm/lb.in.	
Weight	typ.		180	g

Data according to IEC 60747 refer to a single thyristor/diode unless otherwise stated.  
 IXYS reserves the right to change limits, test conditions and dimensions

Symbol	Test Conditions	Characteristic Values		
$I_D, I_R$	$T_{VJ} = T_{VJM}; V_R = V_{RRM}; V_D = V_{DRM}$	≤	5	mA
$V_T$	$I_T = 80 \text{ A}; T_{VJ} = 25^\circ\text{C}$	≤	1.65	V
$V_{TO}$	For power-loss calculations only	0.85	V	
$r_T$		11	mΩ	
$V_{GT}$	$V_D = 6 \text{ V}; T_{VJ} = 25^\circ\text{C}$	≤	1.0	V
	$T_{VJ} = -40^\circ\text{C}$	≤	1.6	V
$I_{GT}$	$V_D = 6 \text{ V}; T_{VJ} = 25^\circ\text{C}$	≤	100	mA
	$T_{VJ} = -40^\circ\text{C}$	≤	150	mA
$V_{GD}$	$T_{VJ} = T_{VJM}; V_D = 2/3 V_{DRM}$	≤	0.2	V
$I_{GD}$		≤	5	mA
$I_L$	$T_{VJ} = 25^\circ\text{C}; t_p = 10 \mu\text{s}$ $I_G = 0.3 \text{ A}; di_G/dt = 0.3 \text{ A}/\mu\text{s}$	≤	200	mA
$I_H$	$T_{VJ} = 25^\circ\text{C}; V_D = 6 \text{ V}; R_{GK} = \infty$	≤	150	mA
$t_{gd}$	$T_{VJ} = 25^\circ\text{C}; V_D = 1/2 V_{DRM}$ $I_G = 0.3 \text{ A}; di_G/dt = 0.3 \text{ A}/\mu\text{s}$	≤	2	μs
$t_q$	$T_{VJ} = T_{VJM}; I_T = 20 \text{ A}, t_p = 200 \mu\text{s}; di/dt = -10 \text{ A}/\mu\text{s}$ $V_R = 100 \text{ V}; dv/dt = 15 \text{ V}/\mu\text{s}; V_D = 2/3 V_{DRM}$	typ.	150	μs
$R_{thJC}$	per thyristor; sine 180°el	1.20	K/W	
	per module	0.20	K/W	
$R_{thJK}$	per thyristor; sine 180°el	1.31	K/W	
	per module	0.218	K/W	
$d_s$	Creeping distance on surface	8.0	mm	
$d_A$	Creepage distance in air	4.5	mm	
$a$	Max. allowable acceleration	50	m/s <sup>2</sup>	

## Dimensions in mm (1 mm = 0.0394")

